NOT RECOMMENDED FOR NEW DESIGNS PLEASE USE ZXTC4591AMC



ZXTD4591AM832

MPPS™ Miniature Package Power Solutions Complementary dual 40V high performance transistor

Summary

NPN Transistor - V_{CEO} = 40V; R_{SAT} = 195m Ω ; I_{C} = 2.5A PNP Transistor - V_{CEO} = -40V; R_{SAT} = 350m Ω ; I_{C} = -2A

Description

Packaged in the 3mm x 2mm MLP (Micro Leaded Package), these high performance NPN / PNP combination dual transistors offer lower on state losses making them ideal for use in DC-DC circuits and various driving and power-management functions.



- Performance capability equivalent to much larger packages
- · Improved circuit efficiency & power levels
- · PCB area and device placement savings
- Lower package height (0.9mm nom)
- · Reduced component count

Features

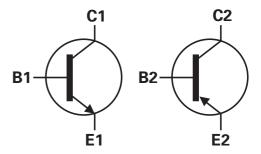
- Low Saturation Voltage (500mV max @1A)
- H_{FF} specified up to 2A
- I_C = 2.5A Continuous Collector Current
- 3mm x 2mm MLP

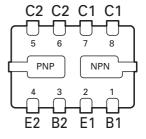
Applications

- DC DC Converters
- · Power switches
- Motor control
- · LED Backlighting circuits

Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTD4591AM832TA	7	8	3,000
ZXTD4591AM832TC	13	8	10,000





Bottom view

Device marking

91A

Absolute maximum ratings

Parameter	Symbol	NPN	PNP	Unit
Collector-Base voltage	V _{CBO}	40	-40	V
Collector-Emitter voltage	V _{CEO}	40	-40	V
Emitter-Base voltage	V _{EBO}	5	-5	V
Peak pulse current	I _{CM}	3	-3	Α
Continuous collector current ^{(a)(f)}	I _C	2	-1.5	Α
Continuous collector current ^{(b)(f)}	I _C	2.5	-2.0	Α
Base current	I _B	30	00	mA
Power dissipation at T _A =25°C ^{(a)(f)}	P _D	1.	.5	W
Linear derating factor		12		mW/°C
Power dissipation at T _A =25°C ^{(b)(f)}	P _D	2.45		W
Linear derating factor		19.6		mW/°C
Power dissipation at T _A =25°C(c)(f)	P _D	1		W
Linear derating factor		8		mW/°C
Power dissipation at T _A =25°C ^{(d)(f)}	P _D	1.13		W
Linear derating factor		9		mW/°C
Power dissipation at T _A =25°C ^{(d)(g)}	P _D	1.7		W
Linear derating factor		13.6		mW/°C
Power dissipation at T _A =25°C ^{(e)(g)}	P _D	3		W
Linear derating factor		24		mW/°C
Storage temperature range	T _{stg}	-55 to +150		°C
Junction temperature range	T _j	150		°C

Thermal resistance

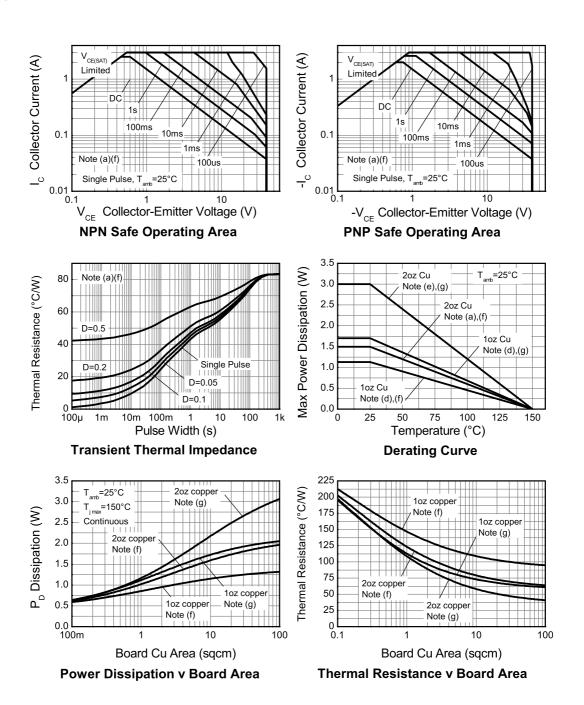
Parameter	Symbol	Value	Unit
Junction to ambient ^{(a)(f)}	$R_{\theta JA}$	83.3	°C/W
Junction to ambient ^{(b)(f)}	$R_{\theta JA}$	51	°C/W
Junction to ambient ^{(c)(f)}	$R_{\theta JA}$	125	°C/W
Junction to ambient ^{(d)(f)}	$R_{\theta JA}$	111	°C/W
Junction to ambient ^{(d)(g)}	$R_{\theta JA}$	73.5	°C/W
Junction to ambient ^{(e)(g)}	$R_{\theta JA}$	41.7	°C/W

NOTES:

- (a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
- (b) Measured at t-5 secs for a dual device surface mounted on 8 sg cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
- (c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.
- (d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
- (e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device
- (f) For a dual device with one active die.
 (g) For dual device with 2 active die running at equal power.
- (h) Repetitive rating pulse width limited by max junction temperature. Refer to Transient Thermal Impedance graph.

 (i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of
- the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 500mW.

Typical characteristics



NPN Transistor

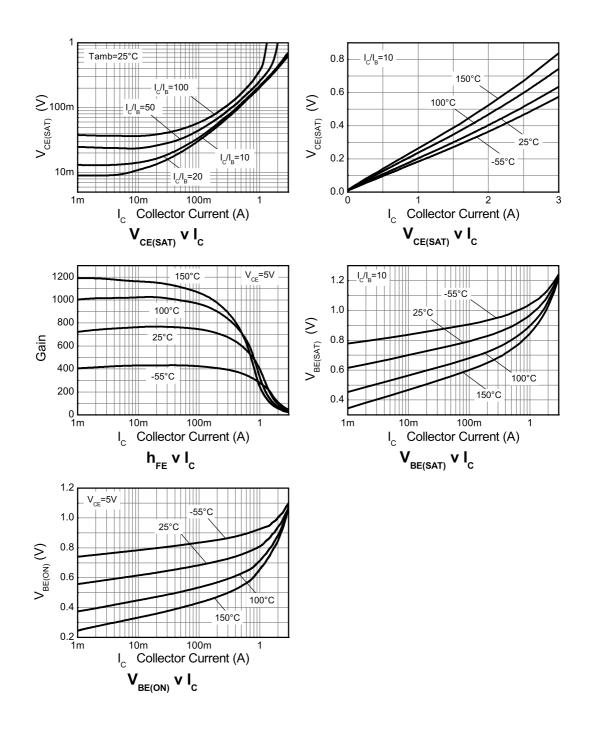
Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base	V _{(BR)CBO}	40			V	$I_{C} = 100 \mu A$
breakdown voltage						
Collector-Emitter	V _{(BR)CEO}	40			V	I _C = 10mA ^(*)
breakdown voltage						
Emitter-Base	V _{(BR)EBO}	5			V	I _E = 100μA
breakdown voltage						
Collector cut-off	I _{CBO}			100	nA	V _{CB} =30V
current						
Emitter cut-off current	I _{EBO}			100	nA	V _{EB} = 4V
Collector Emitter cut-	I _{CES}			100	nV	V _{CE} = 30V
off current						
Collector Emitter	V _{CE(sat)}			300	mV	$I_C = 0.5A$, $I_B = 50mA^{(*)}$
saturation voltage				500	mV	$I_C = 1A$, $I_B = 100 \text{mA}^{(*)}$
Base-Emitter	V _{BE(sat)}			1.1	V	$I_C = 1A$, $I_B = 100 \text{mA}^{(*)}$
saturation voltage						
Base-Emitter turn-on	V _{BE(on)}			1.0	V	$I_C = 1A$, $V_{CE} = 5V^{(*)}$
voltage						
Static forward current	h _{FE}	300				$I_C = 1mA, V_{CE} = 5V^{(*)}$
transfer ratio		300		900		$I_C = 0.5A, V_{CF} = 5V^{(*)}$
		200				$I_C = 1A$, $V_{CF} = 5V^{(*)}$
		35				$I_C = 2A, V_{CE} = 5V^{(*)}$
Transition frequency	f _T	150			MHz	I _C = -50mA, V _{CE} = -10V
						f = 100MHz
Output capacitance	C _{OBO}			10	pF	V _{CB} = -10V, f = 1MHz

NOTES:

(*) Measured under pulsed conditions.

NPN Typical characteristics



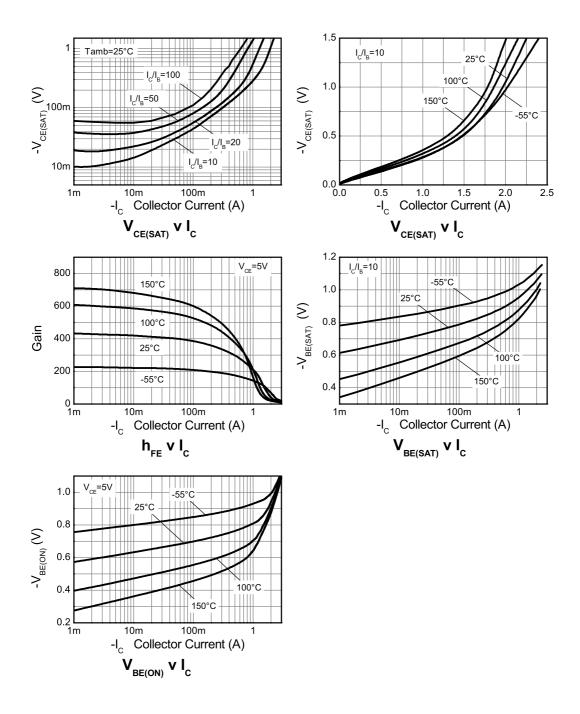
PNP Transistor

Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

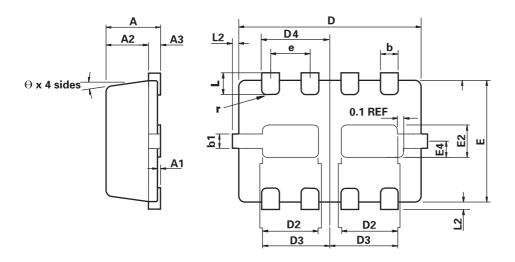
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base	V _{(BR)CBO}	-40			V	$I_C = -100 \mu A$
breakdown voltage						
Collector-Emitter	V _{(BR)CEO}	-40			V	I _C = -10mA ^(*)
breakdown voltage						
Emitter-Base	V _{(BR)EBO}	-5			V	$I_E = -100 \mu A$
breakdown voltage						
Collector cut-off	I _{CBO}			-100	nA	V _{CB} = -30V
current						
Emitter cut-off current	I _{EBO}			-100	nA	V _{EB} = -4V
Collector Emitter cut-	I _{CES}			-100	nV	V _{CE} = -30V
off current						
Collector Emitter	V _{CE(sat)}			-200	mV	$I_C = -0.1A$, $I_B = -1mA^{(*)}$
saturation voltage				-350	mV	$I_C = -0.5A$, $I_B = -20mA^{(*)}$
				-500	mV	$I_C = -1A$, $I_B = -100 \text{mA}^{(*)}$
Base-Emitter	V _{BE(sat)}			-1.1	V	$I_C = -1A$, $I_B = -50 \text{mA}^{(*)}$
saturation voltage						
Base-Emitter turn-on	V _{BE(on)}			-1.0	V	$I_C = -1A$, $V_{CE} = -5V^{(*)}$
voltage						
Static forward current	h _{FE}	300				$I_C = -1 \text{mA}, V_{CE} = -5 V^{(*)}$
transfer ratio		300		800		$I_C = -0.1A$, $V_{CE} = -5V^{(*)}$
		250				$I_C = -0.5A$, $V_{CE} = -5V^{(*)}$
		160				$I_C = -1A$, $V_{CE} = -5V^{(*)}$
		30				$I_C = -2A$, $V_{CE} = -5V^{(*)}$
Transition frequency	f _T	150			MHz	$I_C = -50 \text{mA}, V_{CE} = -10 \text{V}$
						f = 100MHz
Output capacitance	C _{OBO}			10	pF	V _{CB} = -10V, f = 1MHz

(*) Measured under pulsed conditions.

PNP electrical characteristics



Package outline MLP832



Dim.	Millimeters		Inches		Dim.	Millin	neters	Inc	hes
Dilli.	Min.	Max.	Min.	Max.	Dilli.	Min.	Max.	Min.	Max.
Α	0.80	1.00	0.0315	0.0394	е	0.65 BSC		0.0256 BSC	
A1	0.00	0.05	0.00	0.002	Е	2.00 BSC		0.0787 BSC	
A2	0.65	0.75	0.0256	0.0295	E2	0.43	0.63	0.017	0.0248
A3	0.15	0.25	0.006	0.0098	E4	0.16	0.36	0.006	0.014
b	0.24	0.34	0.0095	0.0134	L	0.20	0.45	0.0079	0.0177
b1	0.17	0.30	0.0068	0.0118	L2	0.00	0.125	0.00	0.005
D	3.00	BSC	0.118	BSC	r	0.075	BSC	0.002	9 BSC
D2	0.82	1.02	0.0323	0.0402	θ	0°	12°	0°	12°
D3	1.01	1.21	0.0398	0.0476	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

Definitions

Product change

Zetex Semiconductors reserves the right to alter, without notice, specifications, design, price or conditions of supply of any product or service. Customers are solely responsible for obtaining the latest relevant information before placing orders.

The circuits in this design/application note are offered as design ideas. It is the responsibility of the user to ensure that the circuit is fit for the user's application and meets with the user's requirements. No representation or warranty is given and no liability whatsoever is assumed by Zetex with respect to the accuracy or use of such information, or infringement of patents or other intellectual property rights arising from such use or otherwise. Zetex does not assume any legal responsibility or will not be held legally liable (whether in contract, tort (including negligence), breach of statutory duty, restriction or otherwise) for any damages, loss of profit, business, contract, opportunity or consequential loss in the use of these circuit applications, under any circumstances.

Zetex products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Zetex Semiconductors plc. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body

- 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

The product specifications contained in this publication are issued to provide outline information only which (unless agreed by the company in writing) may not be used, applied or reproduced for any purpose or form part of any order or contract or be regarded as a representation relating to the products or services concerned.

Terms and Conditions

All products are sold subjects to Zetex' terms and conditions of sale, and this disclaimer (save in the event of a conflict between the two when the terms of the contract shall prevail) according to region, supplied at the time of order acknowledgement.

For the latest information on technology, delivery terms and conditions and prices, please contact your nearest Zetex sales office.

Quality of product

Zetex is an ISO 9001 and TS16949 certified semiconductor manufacturer.

To ensure quality of service and products we strongly advise the purchase of parts directly from Zetex Semiconductors or one of our regionally authorized distributors. For a complete listing of authorized distributors please visit: www.zetex.com/salesnetwork

Zetex Semiconductors does not warrant or accept any liability whatsoever in respect of any parts purchased through unauthorized sales channels.

ESD (Electrostatic discharge)

Semiconductor devices are susceptible to damage by ESD. Suitable precautions should be taken when handling and transporting devices. The possible damage to devices depends on the circumstances of the handling and transporting, and the nature of the device. The extent of damage can vary from immediate functional or parametric malfunction to degradation of function or performance in use over time. Devices suspected of being affected should be replaced.

Green compliance

Zetex Semiconductors is committed to environmental excellence in all aspects of its operations which includes meeting or exceeding regulatory requirements with respect to the use of hazardous substances. Numerous successful programs have been implemented to reduce the use of hazardous substances and/or emissions.

All Zetex components are compliant with the RoHS directive, and through this it is supporting its customers in their compliance with WEEE and ELV directives.

Product status key:	
"Preview"	Future device intended for production at some point. Samples may be available
"Active"	Product status recommended for new designs
"Last time buy (LTB)"	Device will be discontinued and last time buy period and delivery is in effect
"Not recommended for new designs"	Device is still in production to support existing designs and production
"Obsolete"	Production has been discontinued
Datasheet status key:	
"Draft version"	This term denotes a very early datasheet version and contains highly provisional information, which may change in any manner without notice.
"Provisional version"	This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. However, changes to the test conditions and specifications may occur, at any time and without notice.
"Issue"	This term denotes an issued datasheet containing finalized specifications. However, changes to specifications may occur, at any time and without notice.

Zetex sales offices

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH	Zetex Inc	Zetex (Asia Ltd)	Zetex Semiconductors plc
Kustermann-Park	700 Veterans Memorial Highway	3701-04 Metroplaza Tower 1	Zetex Technology Park, Chadderton
Balanstraße 59	Hauppauge, NY 11788	Hing Fong Road, Kwai Fong	Oldham, OL9 9LL
D-81541 München	USA	Hong Kong	United Kingdom
Germany			_
Telefon: (49) 89 45 49 49 0	Telephone: (1) 631 360 2222	Telephone: (852) 26100 611	Telephone: (44) 161 622 4444
Fax: (49) 89 45 49 49 49	Fax: (1) 631 360 8222	Fax: (852) 24250 494	Fax: (44) 161 622 4446
europe.sales@zetex.com	usa.sales@zetex.com	asia.sales@zetex.com	hq@zetex.com
0.0000 0.111.1.11.7			

© 2008 Published by Zetex Semiconductors plc